

# Sr<sub>2</sub>YSbO<sub>6</sub> as a buffer layer for YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-δ</sub> superconducting films

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**Abstract** We report the epitaxial growth of Sr<sub>2</sub>YSbO<sub>6</sub> films over a MgO single crystal using magnetron sputtering technique. Sr<sub>2</sub>YSbO<sub>6</sub> films were used as a buffer layer for growth of YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-δ</sub> films by DC sputtering. It was experimentally determined that the films evidence superconducting properties, such as a critical temperature of 90 K and a self-field critical current density at 77 K of 0.8 MA/cm<sup>2</sup>. These results, as well as good lattice matching and chemical stability between Sr<sub>2</sub>YSbO<sub>6</sub> and YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-δ</sub>, suggest that Sr<sub>2</sub>YSbO<sub>6</sub> is an ideal material to be applied as buffer layer for high-performance superconductor coatings. For instance, Sr<sub>2</sub>YSbO<sub>6</sub> material can be used as a single buffer layer in coated conductor tapes based on ion beam assisted deposition of MgO template (IBAD-MgO).

## Introduction

During the past decade, significant advances in the performance levels of high-temperature superconducting (HTS) wire have made it suitable for commercially viable applications such as electric power cables, fault current limiters, motors, and generators [1, 2]. For instance, both the United States Department of Energy and private industry have been developing a key superconductor cable and fault current limiter projects [1], and there is a 5-year Japanese national project for materials and power applications of coated conductors, which was started in 2008 [2]. These power applications share a common requirement: that the superconducting material be formed into a long, strong, and flexible conductor so that it can be used like the copper wire it is intended to replace. And this is where the problems began, because the HTS materials are ceramics that are more like a piece of chalk than the ductile metal copper [3].

The first solution to this problem, the so-called first generation wire, was a tape that was made packing Bi–Sr–Ca–Cu–O (BSCCO) superconducting powder into a silver tube, following a series of rolling and heating steps [4]. In spite of successful applications, this type of conductor is expensive for most commercial applications due to the use of silver.

Further, BSCCO is not suitable for applications such as motors and magnets at liquid nitrogen temperature; it loses its ability to carry super current in a magnetic field [3, 5]. The alternative approach, known as the second generation wire, uses the epitaxial growth of a YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-δ</sub> superconducting coating on a thin metal tape. The advantages of this wire are that very little silver is needed, making it inexpensive, and that the compound YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-δ</sub> retains much higher current-carrying ability in a magnetic field.

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Despite these advantages of superconductors, the ability to carry current without loss is limited to current densities lower than a critical value,  $J_c$ . In order to carry a higher current in a wire, the objective of research efforts is to increase  $J_c$ .

In this context, the preparation of biaxially textured substrates and subsequent epitaxial buffer layers is very important for the realization of long-length  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$ -coated conductors. The buffer layer should not only satisfy chemical stability, but structural matching with  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  as well because the alignment of the superconductor is required for high  $J_c$  values [3, 6].

Different oxide materials have been successfully used as a buffer layer to fulfill these requirements [3, 7–14]. However, most of them are really a multilayer architectures, which significantly increase the complexity as well as the cost of production [6]. Therefore, the development of a single buffer layer is of great interest, as this might simplify the preparation process and lead to a more cost-effective fabrication of coated conductors. To fabricate templates of great length, the most promising approach is, generally, with ion beam assisted deposition, IBAD yttria-stabilized zirconia (YSZ),  $\text{Gd}_2\text{Zr}_2\text{O}_7$  or  $\text{MgO}$  [15–18]. Of these, the best is IBAD-MgO because very good biaxial texture can be obtained with films only 10 nm thick, which reduces production costs [3, 16, 17].

$\text{Sr}_2\text{YSbO}_6$  appears to be a promising material for fulfill these criteria, as it has a lattice parameter exhibiting a good lattice match with  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  (mismatch between  $a$  and  $b$   $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  parameters and  $a$  of  $\text{Sr}_2\text{YSbO}_6$  is  $\sim 5\%$ ). In this article, it has been applied effectively as a buffer layer for  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  film growth by DC sputtering. Schematic representation of the resultant architecture  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$ – $\text{Sr}_2\text{YSbO}_6$ – $\text{MgO}$  is shown in Fig. 1. This superconducting film has a  $J_c$  value  $\sim 10^3$  times that grown on  $\text{MgO}$ .  $\text{Sr}_2\text{YSbO}_6$  films that were deposited over  $\text{MgO}$  single-crystal substrate, because  $\text{Sr}_2\text{YSbO}_6$  has a good match with  $\text{MgO}$ , which is the material of the IBAD-MgO tapes. Other applications for the  $\text{Sr}_2\text{YSbO}_6$  material are in a Josephson junction because they are an insulating material for the deposition of superconductor films in microwave

applications, and for the elaboration of crucibles for the preparation of superconductors due to their chemical non reactivity with  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$ .

The material  $\text{Sr}_2\text{YSbO}_6$  was chosen because we had been working to find new substrates for  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  within the perovskite family  $\text{A}_2\text{BB}'\text{O}_6'$  since by means of substitutions they permit adjusting the lattice parameters [19]. Previous studies of the material in polycrystalline form showed that it was viable as a substrate for the growth of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  films [20], which is effectively shown in this article.

## Experimental details

The deposition of  $\text{Sr}_2\text{YSbO}_6$  buffer layers, on  $\text{MgO}$  (1 0 0) substrate, was performed by magnetron sputtering (13.56 MHz, 70 W) using a polycrystalline target, which was fabricated by the solid state reaction method, based on  $\text{SrO}$ ,  $\text{Sb}_2\text{O}_3$ , and  $\text{Y}_2\text{O}_3$  powder oxides. Detailed  $\text{Sr}_2\text{YSbO}_6$  synthesis processing conditions, and study of structural ordering, can be found elsewhere [19, 21].  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  target was prepared by the solid state reaction method such is described in reference [19].

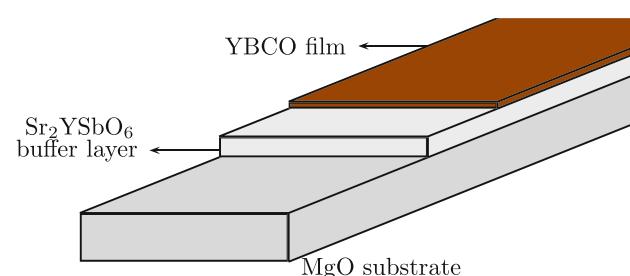
X-ray diffraction patterns, both for the polycrystalline target and for the films, were recorded by a PHILLIPS PW1710 diffractometer using  $\text{Cu-K}\alpha$  radiation ( $\lambda = 1.5406 \text{ \AA}$ ).

The substrate temperature and oxygen pressure for the  $\text{Sr}_2\text{YSbO}_6$  growth were kept at 800 °C and  $7 \times 10^{-3}$  mbar, respectively.  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  films were deposited on these buffer layers by sputtering DC ( $\sim 30$  W) at an optimized substrate temperature of 850 °C and  $\text{O}_2$  pressure of 3.5 mbar for 1 h, followed by cooling up to 550 °C in 30 min at  $\text{O}_2$  pressure of  $\sim 850$  mbar and, therefore, were annealed at 550 °C for 30 min at the same  $\text{O}_2$  pressure.

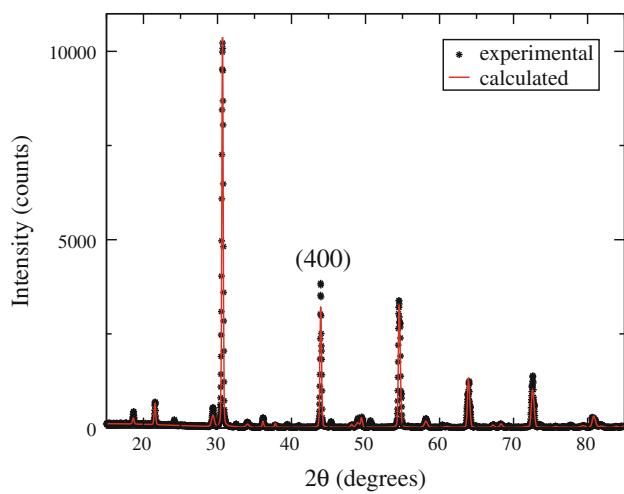
The superconducting properties of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  films were determined by measurements of the transition temperature ( $T_c$ ) and critical current density ( $J_c$ ) at 77 K in self-field, by means of ACT measurements (bias AC current of 30 Hz) with the four-probe method, using the PPMS system of Quantum Design. These measurements were performed on  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  micro bridges, with 20  $\mu\text{m}$  of width and 100 nm of thickness, which were prepared by UV photolithography.

## Results and discussion

The X-ray diffraction pattern of  $\text{Sr}_2\text{YSbO}_6$  polycrystalline target is shown in Fig. 2. The Rietveld refinement, performed with the EXPGUI and GSAS programs [22, 23], reveals that the  $\text{Sr}_2\text{YSbO}_6$  has the expected typical



**Fig. 1** Schematic representation of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  films on  $\text{Sr}_2\text{YSbO}_6$  buffer layer

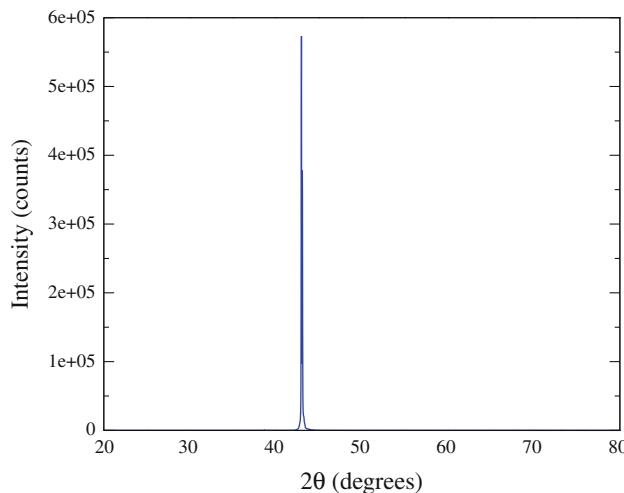


**Fig. 2** XRD pattern of  $\text{Sr}_2\text{YSbO}_6$  polycrystalline target

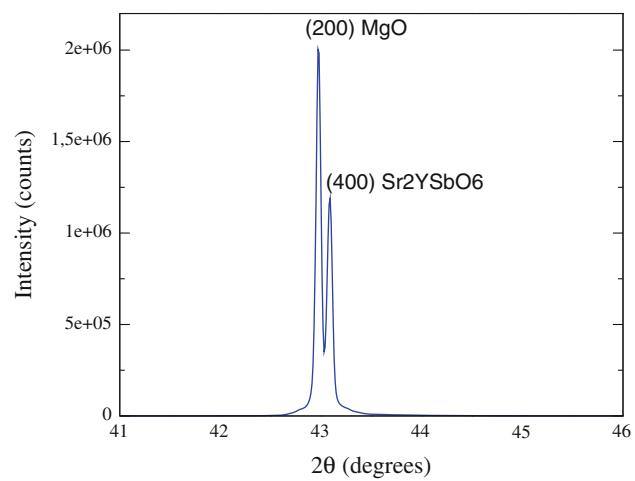
structural ordering of a complex cubic perovskite with lattice parameter  $a = 8.249 \text{ \AA}$ .

Figure 3 shows the X-ray diffraction pattern for the film of  $\text{Sr}_2\text{YSbO}_6$ , with 2 h of deposition for  $2\theta$  between  $10^\circ$  and  $90^\circ$ . It consists of strong peaks (2 0 0) of  $\text{MgO}$  and (4 0 0) of  $\text{Sr}_2\text{YSbO}_6$ . Figure 4 shows a short detailed scan for  $2\theta$  between 41 and 46. It shows the  $\text{MgO}$  peak in  $2\theta = 43^\circ$  and the  $\text{Sr}_2\text{YSbO}_6$  peak in  $2\theta = 43.1^\circ$ . This result reveals the epitaxial growth of  $\text{Sr}_2\text{YSbO}_6$  films on  $\text{MgO}$  (1 0 0) substrate.

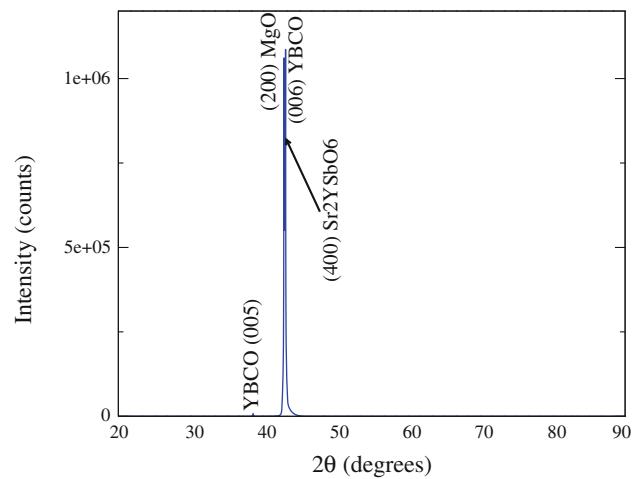
The X-ray diffraction pattern for the film of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  growth over  $\text{Sr}_2\text{YSbO}_6$  buffer layer, for  $2\theta$  between  $10^\circ$  and  $90^\circ$ , is shown in Fig. 5. It consists of peaks (0 0  $l$ ) of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$ , besides the  $\text{MgO}$  and  $\text{Sr}_2\text{YSbO}_6$  peaks, such as is detailed in Fig. 6. These result reveals the epitaxial growth of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  over  $\text{Sr}_2\text{YSbO}_6/\text{MgO}$  buffered substrate.



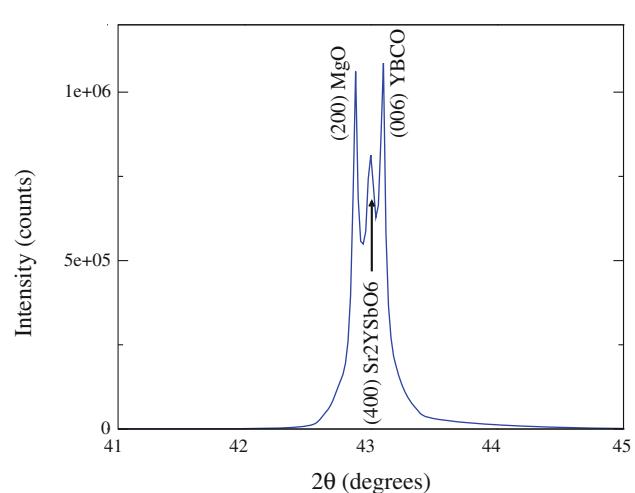
**Fig. 3** XRD of  $\text{Sr}_2\text{YSbO}_6$  films, for  $2\theta$  between  $10^\circ$  and  $90^\circ$



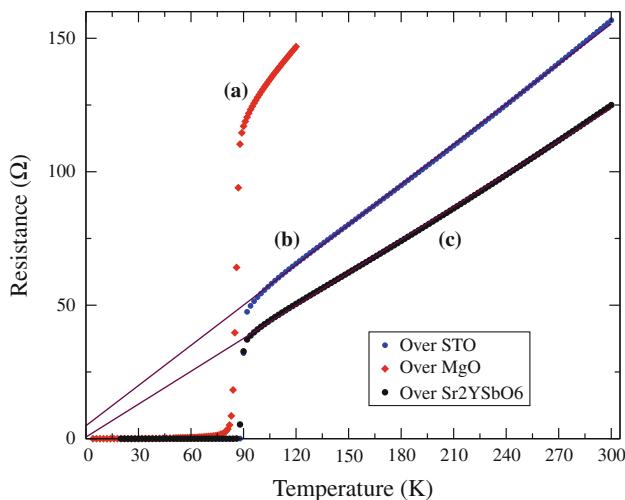
**Fig. 4** Detailed XRD pattern of  $\text{Sr}_2\text{YSbO}_6$  films



**Fig. 5** XRD pattern of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  buffered films



**Fig. 6** Detailed XRD pattern of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  films

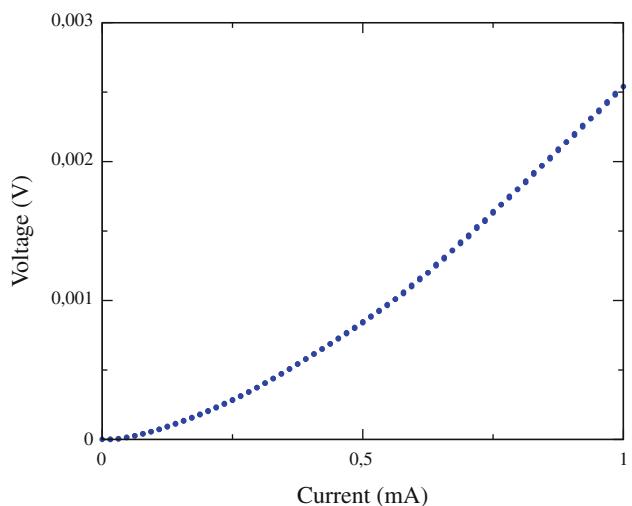


**Fig. 7** Resistance in function of temperature for  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  films over different substrates: (a) over MgO single crystal; (b) over  $\text{SrTiO}_3$  single crystal; and (c) over  $\text{Sr}_2\text{YSbO}_6/\text{MgO}$  buffered substrate

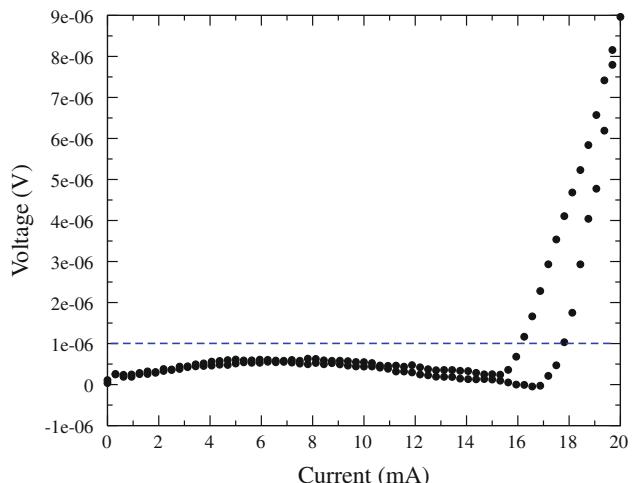
Figure 7 shows the behavior of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  film's resistance as a function of temperature. For films growth over  $\text{Sr}_2\text{YSbO}_6$  the curve exhibits linear behavior up to a transition temperature  $T_c$  of 90 K. In the same figure the measurements corresponding to a  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  films growth over MgO and on  $\text{SrTiO}_3$ , with the same conditions, are shown. The  $T_c$  of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  films over MgO is 86 K, and over  $\text{SrTiO}_3$  is 90 K. Although the  $T_c$  values are similar for films over STO and over  $\text{Sr}_2\text{YSbO}_6$  buffer layer, the resistance in the normal zone is less for the  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  growth on buffer layer; also, the extrapolated residual resistance for this film ( $0.62 \Omega$ ) is less than the residual resistance ( $4.86 \Omega$ ) of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  film growth on  $\text{SrTiO}_3$ .

Results of measurements for voltage  $V$  in function of current  $I$  ( $I$ - $V$  curves) are shown in Figs. 8 and 9 for the films of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  over MgO and over buffered substrate  $\text{Sr}_2\text{YSbO}_6/\text{MgO}$ , respectively. Based on  $I$ - $V$  data, with the  $1 \mu\text{V}/\text{cm}$  criteria, the critical current values were determined in 0.013 and 16.5 mA, respectively. So, the critical current density value for  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  films growth over  $\text{Sr}_2\text{YSbO}_6$  buffer layer is  $J_c \sim 0.8 \text{ MA/cm}^2$ , which is 1269 times the  $J_c$  of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}/\text{MgO}$  films.

The  $J_c$  value for  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}/\text{Sr}_2\text{YSbO}_6/\text{MgO}$  films growth over buffer layer appears to be less than those reported in the literature ( $J_c \sim 10^7 \text{ A/cm}^2$ ). However, it is worth saying that the value for  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}/\text{MgO}$  is less too in comparison with references ( $J_c \sim 10^6 \text{ A/cm}^2$ ). Thus, the sputtering deposition conditions perhaps are not yet optimized, and we believe that with other methods of deposition, such as PLD, we could improve the  $J_c$  results. The results reported in the literature are for films deposited in wealthy laboratories that have optimized deposition conditions.



**Fig. 8**  $I$ - $V$  curves for  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}/\text{MgO}$  film at 77 K



**Fig. 9**  $I$ - $V$  curves for  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  film over  $\text{Sr}_2\text{YSbO}_6/\text{MgO}$  buffered substrate at 77 K. The dashed line is a guide for the eye. It shows the voltage value of  $1 \mu\text{V}$

## Conclusion

Although the optimal deposition conditions for  $\text{Sr}_2\text{YSbO}_6$  films are not yet known, we have shown that  $\text{Sr}_2\text{YSbO}_6$  can be successfully used as a buffer layer for the epitaxial growth of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  films with high density current value in self-field at 77 K. Taking into account that there is evidence of the effect of buffer layer thickness on  $J_c$  [9] and that the  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  deposition conditions can be improved, our values of  $J_c$  could be greater than those reported in this article.

It is worth saying that the layer of  $\text{Sr}_2\text{YSbO}_6$  material that was used plays the role of a buffer layer because the negative effects of MgO over superconducting properties of  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  films were eliminated, and because it has an excellent structural matching with  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  and

with MgO. These results show that  $\text{Sr}_2\text{YSbO}_6$  can be an excellent substrate material for the  $\text{YBa}_2\text{Cu}_3\text{O}_{7-\delta}$  layers in coated conductors, using the IBAD-MgO templates. Besides which, with the  $\text{Sr}_2\text{YSbO}_6$  material the architecture of the coated conductors can be simplified, because only one buffer layer is needed with  $\text{Sr}_2\text{YSbO}_6$ .

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